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	Application No.	Applicant(s)	
Notice of Allowability	10/807,750	LIN ET AL.	
Notice of Allowability	Examiner	Art Unit	
	Christopher P Bruenjes	1772	
The MAILING DATE of this communication apperation apperation allowable, PROSECUTION ON THE MERITS IS (herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHT of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this apport or other appropriate communication GHTS. This application is subject to	olication. If not include will be mailed in due	ed course. <b>THIS</b>
1. This communication is responsive to the after final amenda	nent filed March 10, 2005.		
2. The allowed claim(s) is/are 1-9 and 11.			
3. $\boxtimes$ The drawings filed on <u>24 March 2004</u> are accepted by the B	Examiner.		
<ul> <li>4. Acknowledgment is made of a claim for foreign priority un a) All b) Some* c) None of the:  1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents have International Bureau (PCT Rule 17.2(a)).  * Certified copies not received:  Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.</li> <li>5. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give 6. CORRECTED DRAWINGS (as "replacement sheets") mus (a) including changes required by the Notice of Draftspers  1) hereto or 2) to Paper No./Mail Date  (b) including changes required by the attached Examiner's Paper No./Mail Date  Identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the company of the paper No. INFORMATION about the depose attached Examiner's comment regarding REQUIREMENT in the company of the paper No.</li> </ul>	been received.  been received in Application No cuments have been received in this communication to file a reply ENT of this application.  itted. Note the attached EXAMINER es reason(s) why the oath or declara t be submitted. on's Patent Drawing Review ( PTO- s Amendment / Comment or in the Comment or in the Comment of BIOLOGICAL MATERIAL resit of BIOLOGICAL MATERIAL resit of BIOLOGICAL MATERIAL residence in the design of the de	national stage applical complying with the recomplying attached of the state	quirements OTICE OF
Attachment(s)  1. Notice of References Cited (PTO-892)  2. Notice of Draftperson's Patent Drawing Review (PTO-948)  3. Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date  4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	5. ☐ Notice of Informal P 6. ☑ Interview Summary Paper No./Mail Dat 8), 7. ☑ Examiner's Amendr 8. ☑ Examiner's Stateme 9. ☐ Other	(PTO-413), e <u>20050404</u> . nent/Comment	ŕ



## EXAMINER'S AMENDMENT

- 1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.
- 2. The application has been amended as follows:

In the first sentence of the specification: add "now US patent number 6,777,045," after "June 27, 2001," in line 9 of the first page of the specification.

Cancel claims 12-17.

This application is in condition for allowance except for the presence of claims 12-17 to an invention non-elected without traverse. Accordingly, claims 12-17 have been cancelled.

3. The following is an examiner's statement of reasons for allowance: The closest prior art Shih et al and Chang et al both fail to teach implicitly or explicitly average skewness values of less than about -0.1. An unexpected result presented

by the Applicant that the adherence of sputtered material dramatically increases as a result of a negative skewness value less than -0.1 compared to a skewness value greater than -0.1 as taught by Shih et al or Chang et al enables the processing chamber to form substrates with less sputtered material falling from the exposed chamber walls. Although there is art teaching roughened surfaces with a negative skewness value, the art does not pertain to processing chambers with a dielectric material and a ceramic coating and is considered non-analogous art in an obviousness rejection. Therefore, the combination of limitations presented in independent claims 1 and 9 regarding an enclosure wall comprising aluminum oxide and ceramic coating composed of aluminum oxide having a roughness with a skewness value less than about -0.1, renders the claims allowable.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Christopher P Bruenjes whose telephone number is 571-272-1489.

Application/Control Number: 10/807,750

Art Unit: 1772

Page 4

The examiner can normally be reached on Monday thru Friday from 8:00am-4:30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Harold Pyon can be reached on 571-272-1498. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Christopher P Bruenjes Examiner Art Unit 1772

Art Unit 1772 C.P.B

CPB

April 4, 2005

HAROLD PYON

SUPERVISORY PATENTED